

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HOSOYA, FUTOSHI	
		Examiner Alexander O Williams	Art Unit 2826	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,493,249 B2	12-2002	Shirakawa et al.	363/147
*	B	US-6,774,466 B1	08-2004	Kajiwara et al.	257/673
*	C	US-2004/0065947 a1	04-2004	Sugiyama et al.	257/688
*	D	US-6,469,907 B1	10-2002	Faveluke et al.	361/760
*	E	US-6,246,583 B1	06-2001	Cronin et al.	361/704
*	F	US-6,519,154 B1	02-2003	Chiu, Chia-Pin	361/704
*	G	US-6,515,861 B1	02-2003	Andric et al.	361/709
*	H	US-6,392,888 B1	05-2002	Chen et al.	361/704
*	I	US-5,699,610	12-1997	Shimada et al.	29/840
*	J	US-5,371,404 A	12-1994	Juskey et al.	257/659
*	K	US-5,311,402 A	05-1994	Kobayashi et al.	361/760
*	L	US-6,205,026 B1	03-2001	Wong et al.	361/704
*	M	US-6,791,184 B2	09-2004	Deeney et al.	257/726

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.